

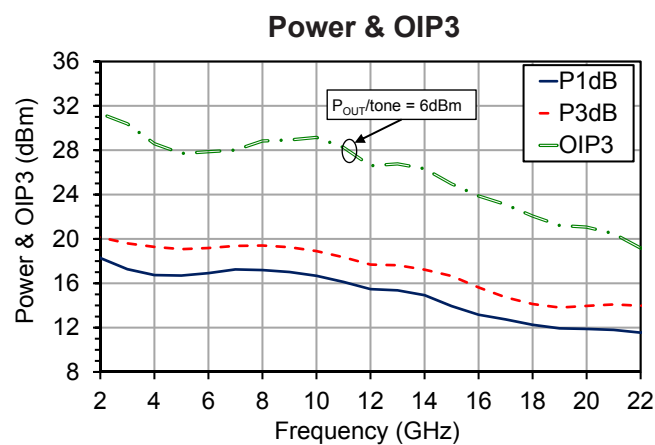
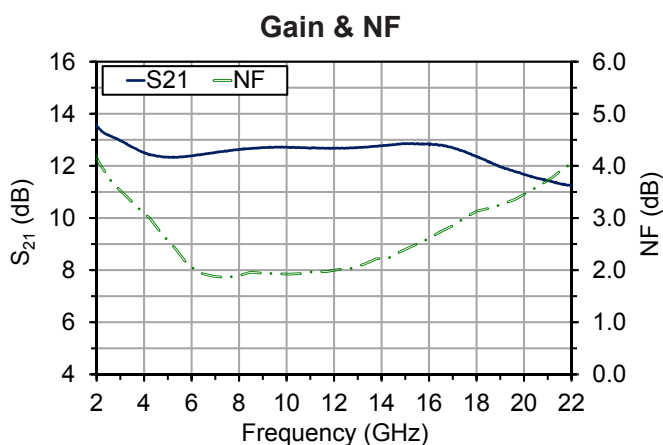
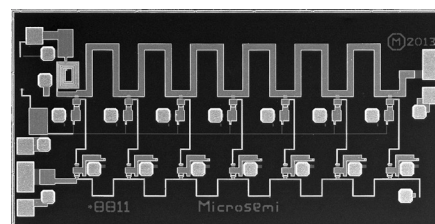
2-20GHz, 12.5dB Gain Low-Noise Wideband Distributed Amplifier

Features

- >16.5dBm P_{1dB} with 1.9dB NF and 12.5dB gain at 10GHz
- <2dB NF from 6-12GHz
- Single supply voltage of +8V @ 50mA
- Input and Output matched to 50Ω
- 1.5mm x 2.82mm x 0.1mm die size

Applications

- Instrumentation
- Electronic warfare
- Microwave communications
- Radar



Typical Performance (CW, Typical Device, RF Probe): $T_A = 25^\circ\text{C}$, $V_{DD} = 8\text{V}$

Parameter	Min	Typ	Max	Units
Frequency	2	-	22	GHz
Small Signal Gain	11.3	-	13.5	dB
Noise Figure	1.9	2.5	4.0	dB
Output Power, P_{1dB}	12	14	18	dBm
Output Power, P_{3dB}	14	18	20	dBm
Output IP3	19	26	31	dBm
Drain Current		50		mA

Table 1: Absolute Maximum Ratings, Not Simultaneous

Parameter	Rating	Units
Drain Voltage (V_D)	+9	V
Input Power (P_{IN})	24	dBm
Channel Temperature (T_C)	150 ¹	°C
Operating Ambient Temperature (T_A)	-55 to +85	°C
Storage Temperature	-65 to +150	°C
Thermal Resistance, Channel to Die Backside	40	°C/W

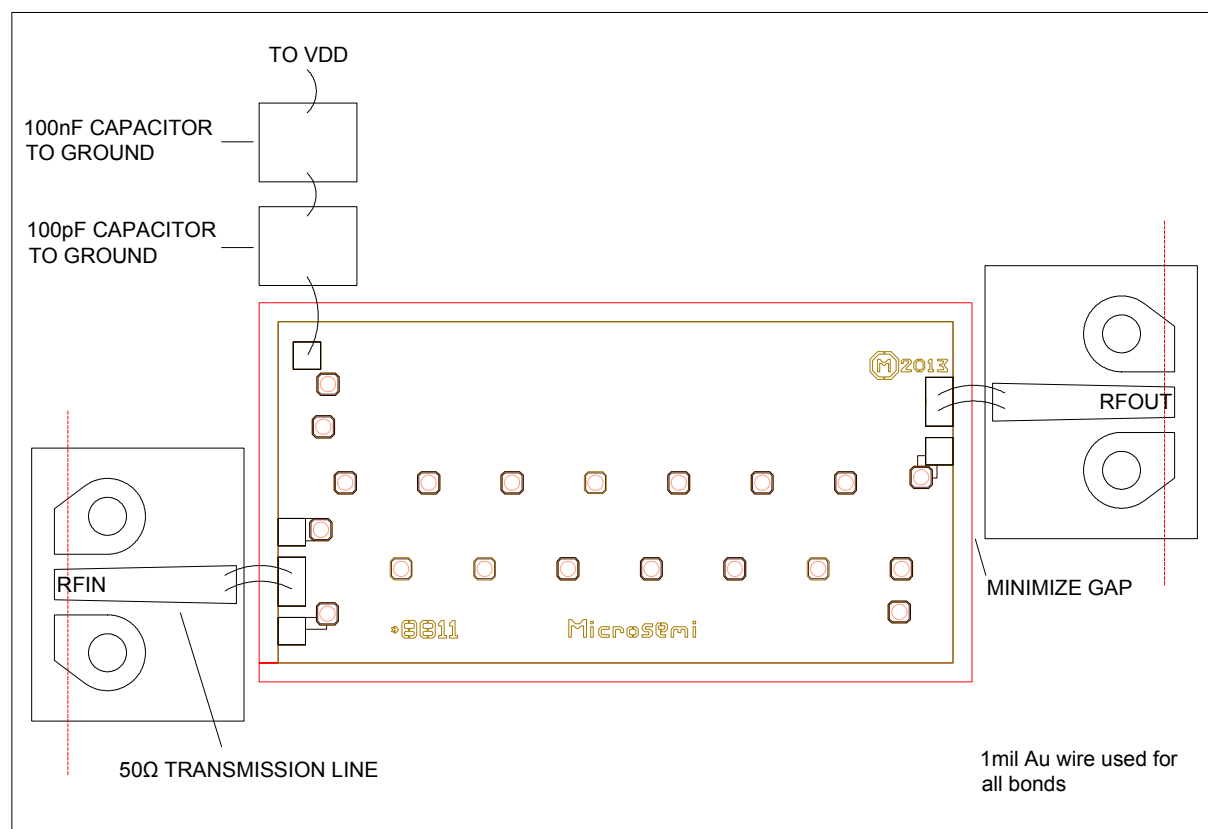
¹ MTTF > 10⁸ hours at $T_C = 150^\circ\text{C}$


Caution, ESD
Sensitive Device

Table 2: Specifications (CW, 100% Test): $T_A = 25^\circ\text{C}$, $V_{DD} = 8\text{V}$

Parameter		Min	Max	Units
I_{DD}	-	-	105	mA
Small Signal Gain	20GHz	9.5	-	dB
Output Power, P_{1dB}	20GHz	9.0	-	dBm

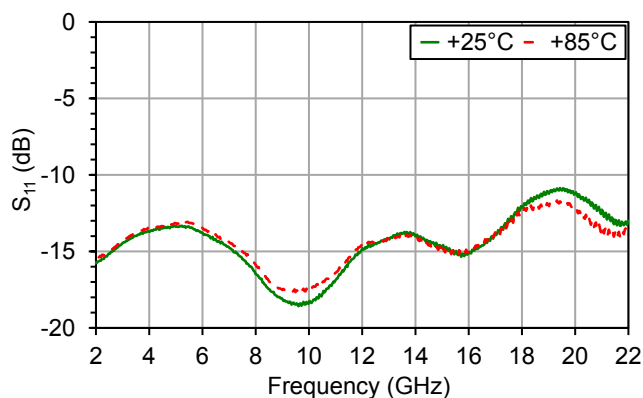
RF Probe Measurement Set-Up With Reference Planes²


² Reference planes are the same for S-parameter files downloadable on www.microsemi.com/mmics

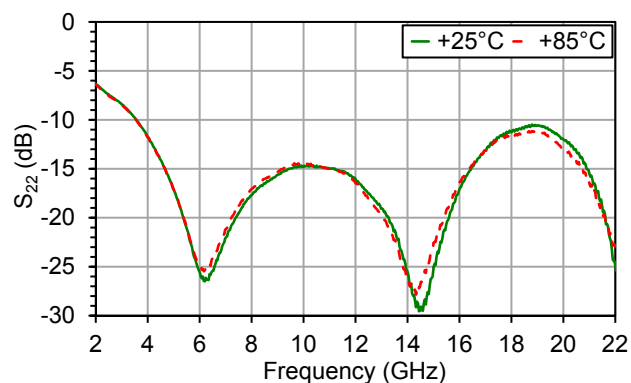
Typical Performance, RF Probe

$V_{DD} = 8V$, $I_{DD} = 50mA$, $T_A = 25^\circ C$ unless otherwise noted

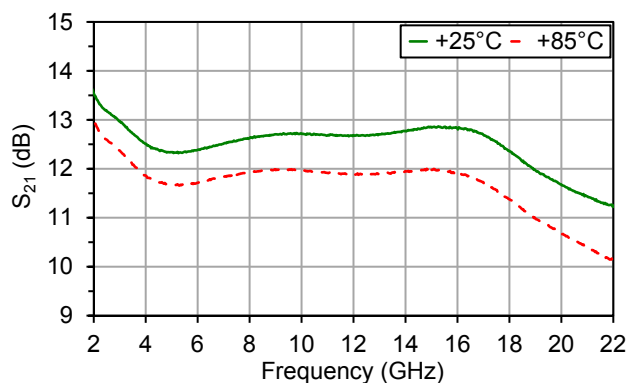
S_{11} Over Temperature



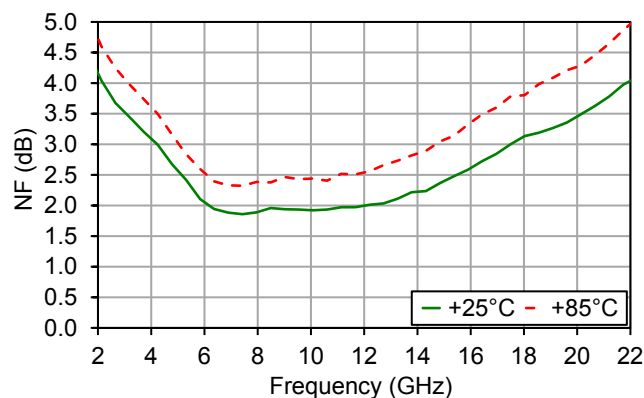
S_{22} Over Temperature



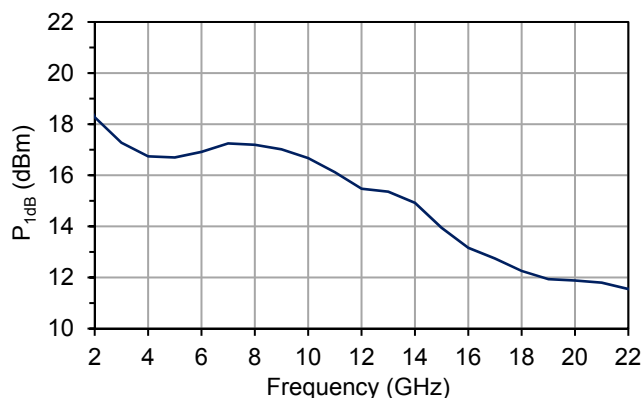
S_{21} Over Temperature



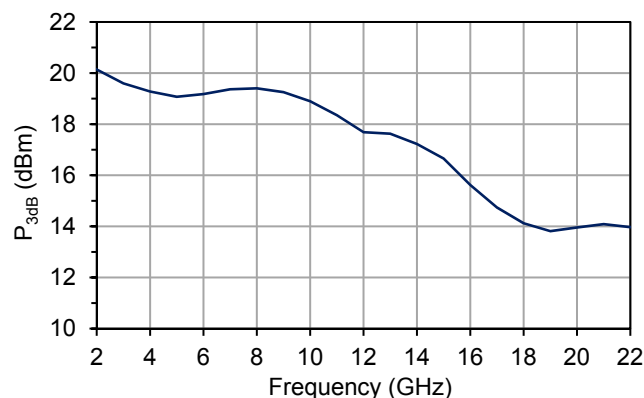
NF Over Temperature



P_{1dB} Over Frequency



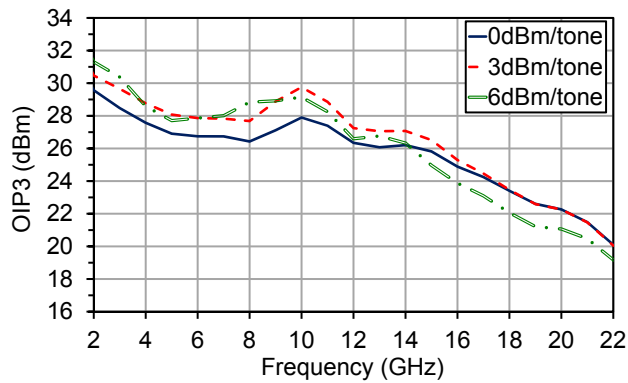
P_{3dB} Over Frequency



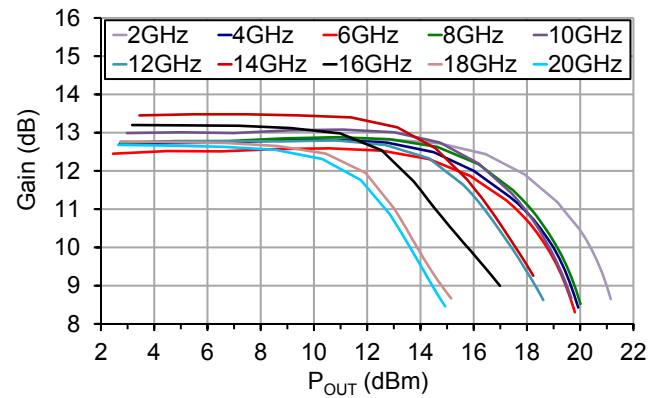
Typical Performance, RF Probe

$V_{DD} = 8V$, $I_{DD} = 50mA$, $T_A = 25^\circ C$ unless otherwise noted

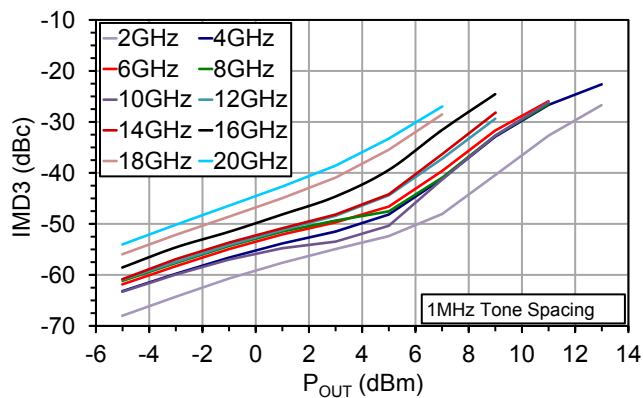
OIP3 Over P_{OUT}



Power Sweep

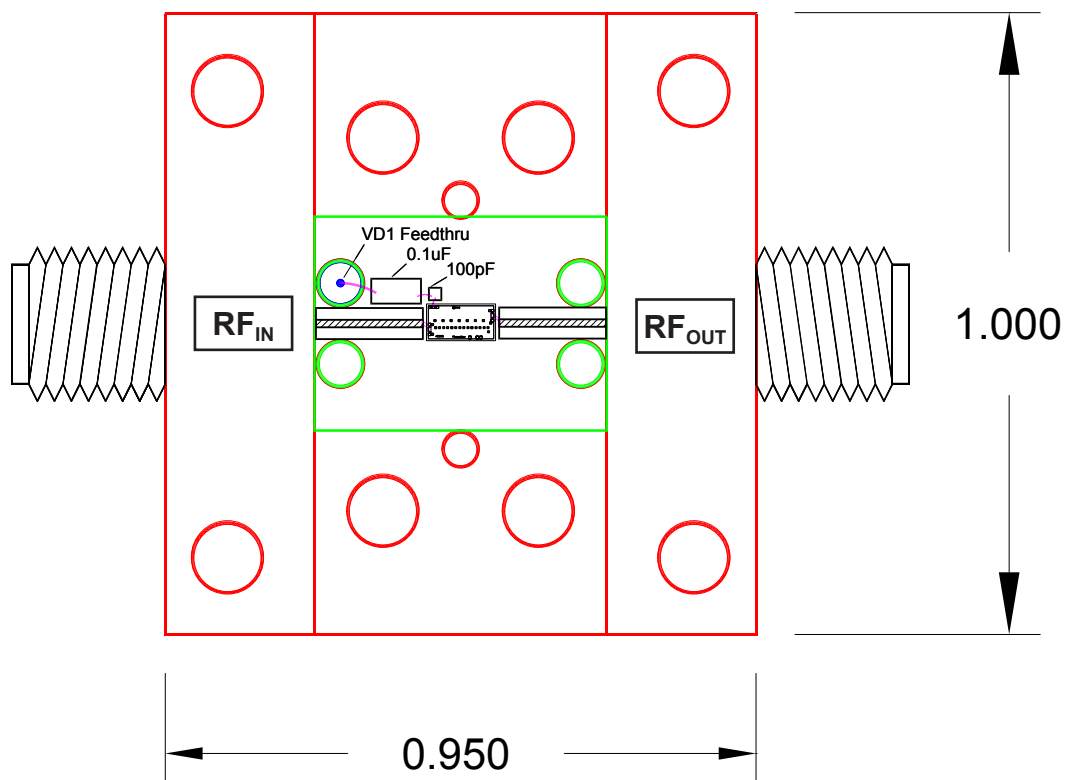


IMD3 Sweep



Connectorized Test Fixture

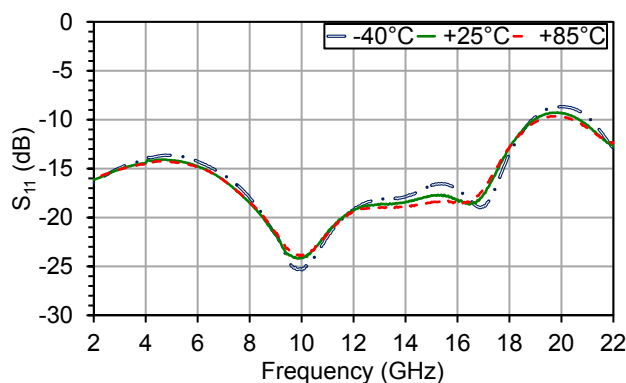
With SMK 2.92mm Connectors



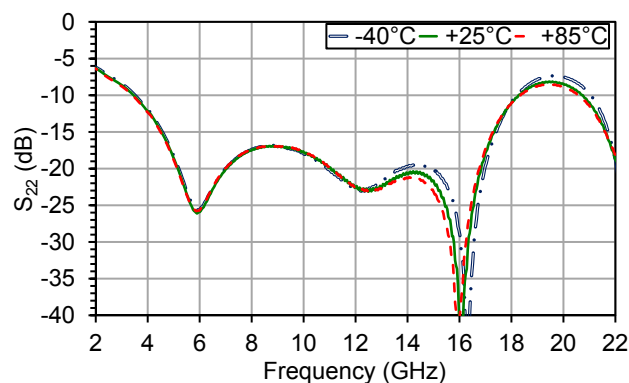
Typical Performance, Connectorized Test Fixture

$V_{DD} = 8V$, $I_{DD} = 50mA$, $T_A = 25^\circ C$ unless otherwise noted

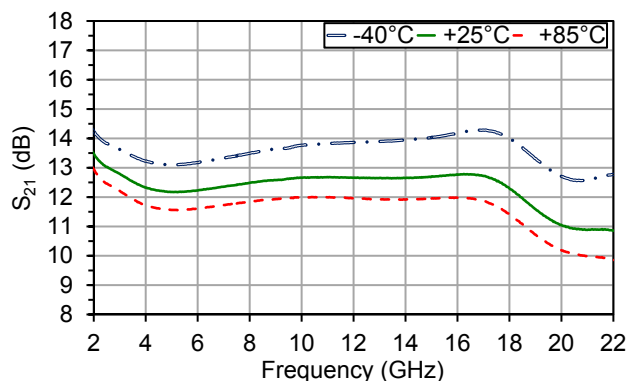
S_{11} Over Temperature



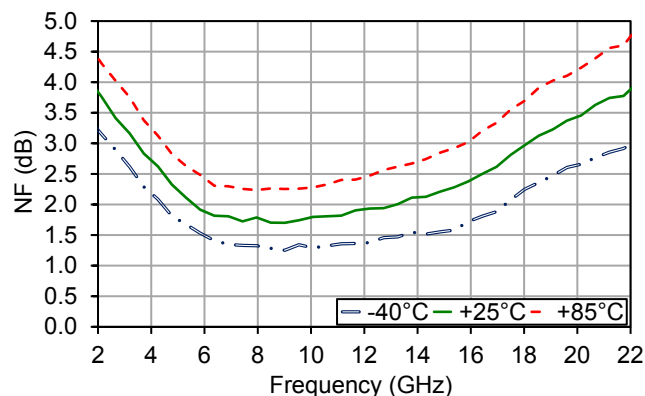
S_{22} Over Temperature



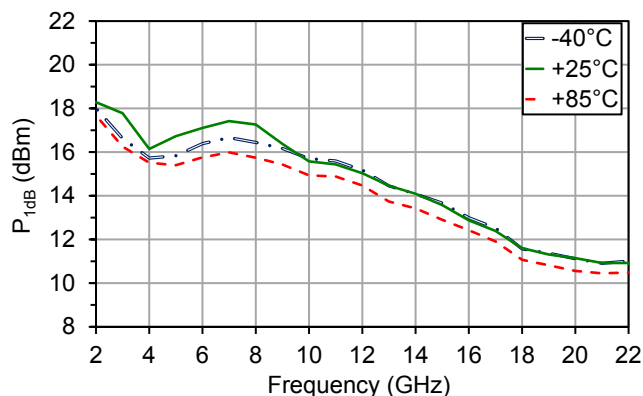
S_{21} Over Temperature



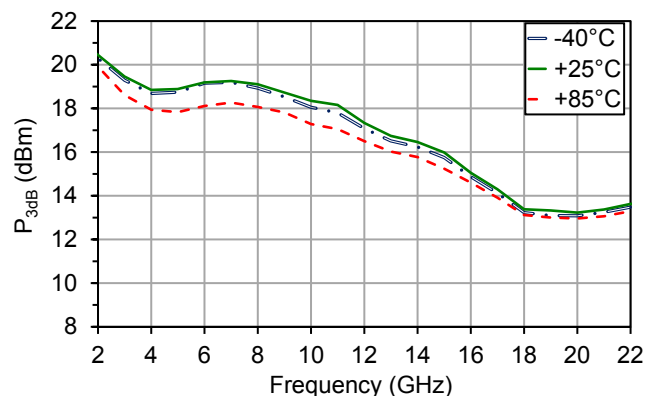
NF Over Temperature



P_{1dB} Over Temperature



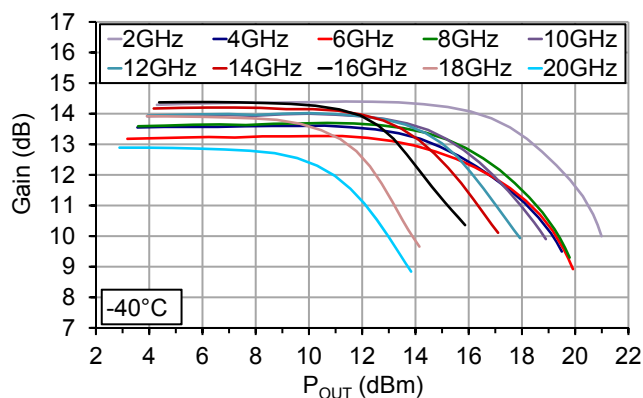
P_{3dB} Over Temperature



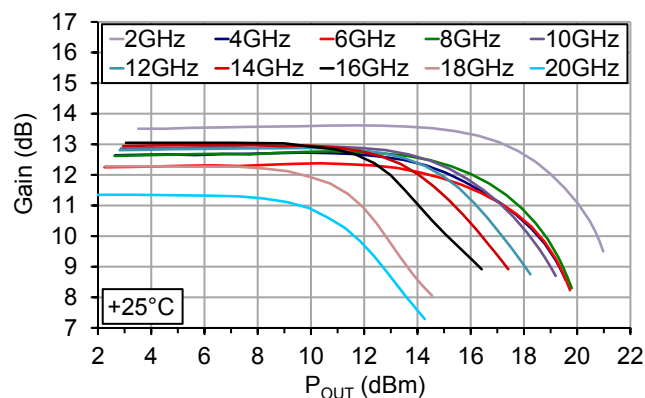
Typical Performance, Connectorized Test Fixture

$V_{DD} = 8V$, $I_{DD} = 50mA$, $T_A = 25^\circ C$ unless otherwise noted

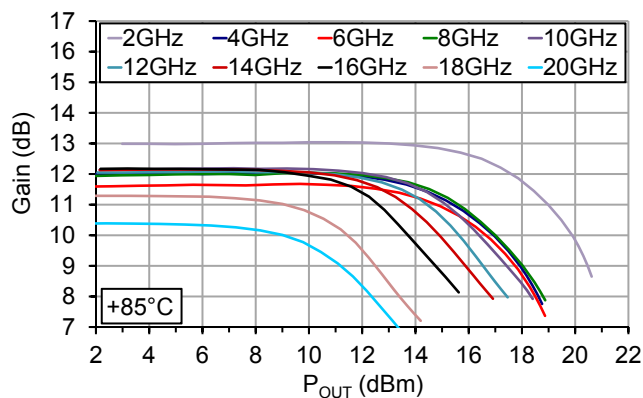
Power Sweep, $-40^\circ C$



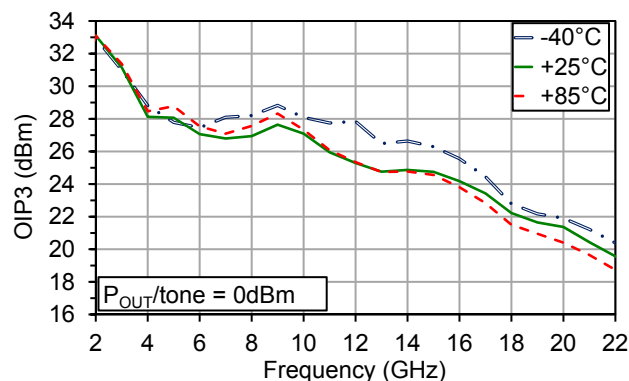
Power Sweep, $+25^\circ C$



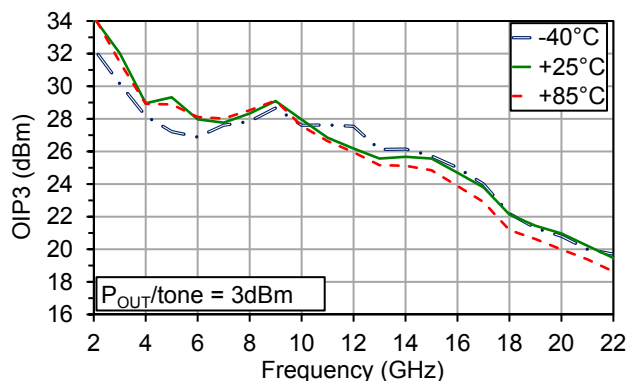
Power Sweep, $+85^\circ C$



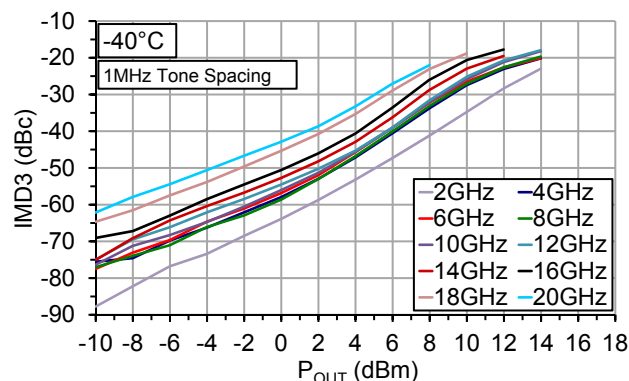
OIP3, 0dBm/tone



OIP3, 3dBm/tone



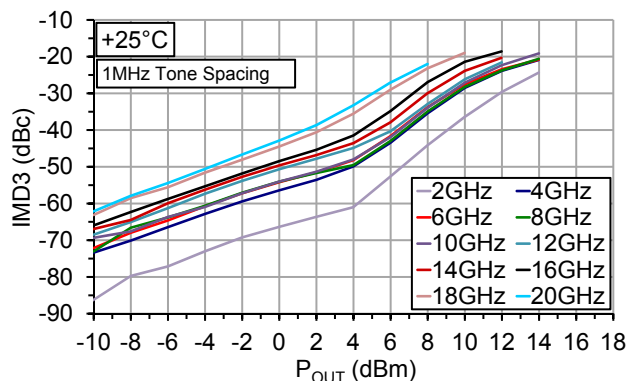
IMD3 Sweep, $-40^\circ C$



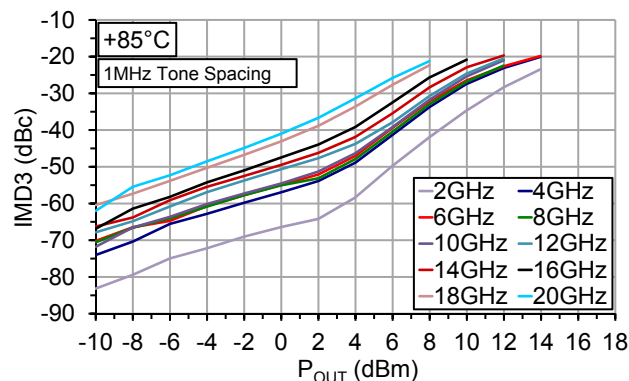
Typical Performance, Connectorized Test Fixture

$V_{DD} = 8V$, $I_{DD} = 50mA$, $T_A = 25^\circ C$ unless otherwise noted

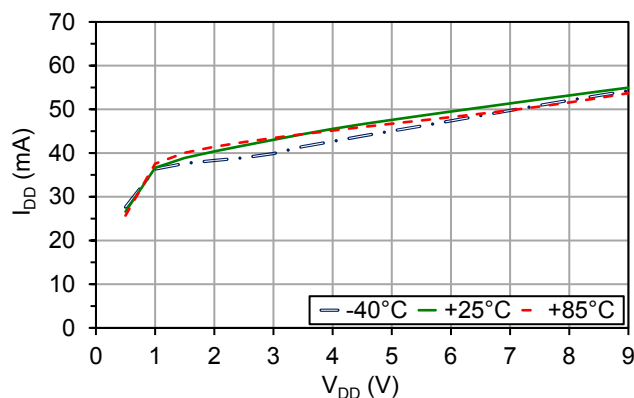
IMD3 Sweep, $+25^\circ C$, 1MHz Tone Spacing



IMD3 Sweep, $+85^\circ C$, 1MHz Tone Spacing



DC



Chip layout showing pad locations.

All dimensions are in microns. Die thickness is 100 microns. Backside metal is gold, bond pad metal is gold.
Refer to Die Handling Application Note MM-APP-0001 (visit www.microsemi.com/mmics).

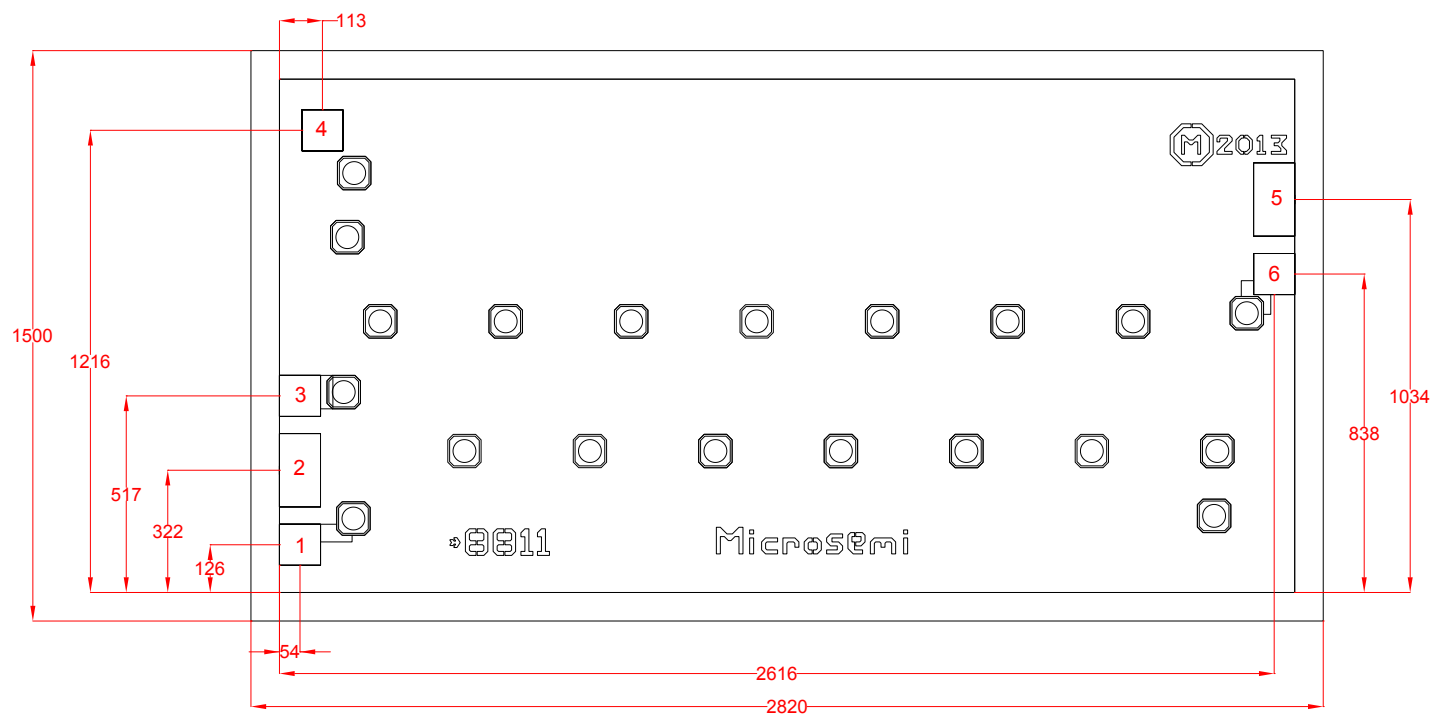


Table 3: Pad Descriptions

Pad #	Description	Pad Dimensions (μm)
1, 3, 6	Ground	100 x 100
2	RF_{IN} , AC Coupled	100 x 190
5	RF_{OUT} , AC Coupled	100 x 190
4	V_{DD}	100 x 100

Biasing

MMA003AA is a self-biased device with single positive supply. Apply V_{DD} to pad 4.

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